Key Parameters

V_{DRM}	=	2000	V
I_{TAVM}	=	1270	A
t_q	=	60	µs
I_{TSM}	=	15000	A
V_{TO}	=	1.25	V
r_T	=	0.430	mΩ

Fast Switching Thyristor

5STF 08F2060

Doc. No. 5SYA 1045-02 Feb.99

Features

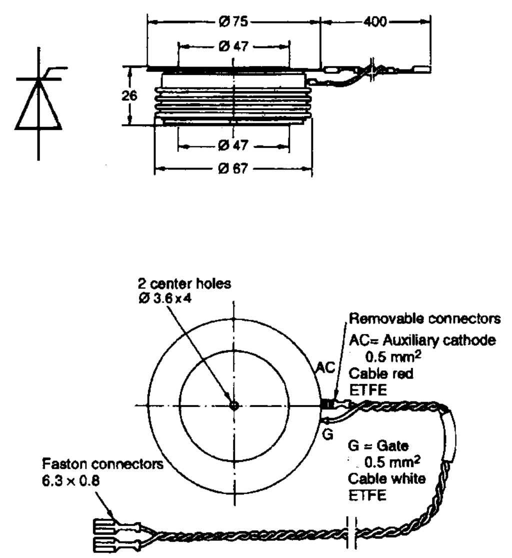
- **Patented free-floating silicon technology**
- **Designed for traction and industrial applications**
- **Optimum switching performance**

Blocking

Part number	5STF 08F2060	5STF 08F1860	5STF 08F1660	Conditions	
V_{DRM} V_{RRM}	2000 V	1800 V	1600 V	f = 50Hz, t_p = 10ms	
V_{RSM1}	2100 V	1900 V	1700 V	t_p = 5ms, single pulse	
I_{DRM}	≤ 150 mA			V_{DRM}	T_{vj} = 125°C
I_{RRM}	≤ 150 mA			V_{RRM}	
dv/dt_{crit}	1000 V/µs		@ Exp.to $0.67xV_{DR}$		

Mechanical data

F_m	Mounting force	nom	22 kN
		min	14 kN
		max	24 kN
a	Acceleration Device clamped		100 m/s²
m	Weight		0.60 kg
D_s	Surface creepage distance		25 mm
D_a	Air strike distance		14 mm



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On-state

I_{TAVM}	Max. average on-state current	1270 A	Half sine wave, T_c = 70°C	
I_{TRMS}	Max. RMS on-state current	2000 A		
I_{TSM}	Max. peak non-repetitive surge current	15000 A	t_p = 10 ms	T_{vj} = 125°C
		16000 A	t_p = 8.3 ms	
I^2t	Limiting load integral	1125 kA²s	t_p = 10 ms	
		1067 kA²s	t_p = 8.3 ms	
V_T	On-state voltage	2.10 V	I_T = 2000 A	
V_{TO}	Threshold voltage	1.25 V		
r_T	Slope resistance	0.430 mΩ	I_T = 600 - 1800 A	
I_H	Holding current	30-70 mA	T_{vj} = 25°C	
		15-50 mA	T_{vj} = 125°C	
I_L	Latching current	150-600 mA	T_{vj} = 25°C	
		75-400 mA	T_{vj} = 125°C	

Switching

di/dt_{crit}	Critical rate of rise of on-state current		300 A/µs	Cont.	$V_D \le 0.67$x V_{DRM} T_{vj} = 125°C I_{TRM} = 2000 A f = 50Hz I_{FG} = 1.5 A t_r = 0.5µs
			600 A/µs	60 sec.	
t_d	Delay time		≤ 2.0 µs	V_D =0.4xV_{DRM}	I_{FG} = 1.5 A t_r = 0.5µs
t_q	Turn-off time		≤ 60 µs	V_D ≤0.67xV_{DRM} dv_D/dt=20 V/µs	I_{TRM} = 2000 A T_{vj} = 125°C V_R > 200 V di_T/dt= -20 A/µs
Q	Recovery charge	min	350 µAs		
		max	560 µAs		

Triggering

V_{GT}	Gate trigger voltage	4.0 V	T_{vj} = 25°C
I_{GT}	Gate trigger current	400 mA	T_{vj} = 25°C
V_{GD}	Gate non-trigger voltage	0.3 V	V_D = 0.4xV_{DRM}
I_{GD}	Gate non-trigger DC current	10 mA	V_D = 0.4xV_{DRM}
V_{FGM}	Peak forward gate voltage	20 V	
I_{FGM}	Peak forward gate current	5 A	
V_{RGM}	Peak reverse gate voltage	10 V	
P_G	Gate power losses	3 W	

Thermal

$T_{vj\ max}$	Max. junction temperature	125 °C	
$T_{vj\ stg}$	Storage temperature range	-40.. ..150°C	
R_{thJC}	Thermal resistance junction to case	28 K/kW	Anode side cooled
		35 K/kW	Cathode side cooled
		15 K/kW	Double side cooled
R_{thCH}	Thermal resistance case to heat sink	20 K/kW	Single side cooled
		10 K/kW	Double side cooled

Analytical function for transient thermal impedance:

$$Z_{thJC} = \sum_{i=1}^{n} R_i(1-e^{-t/\tau_i})$$

i	1	2	3	4
R_i (K/W)	0.0046	0.0068	0.0027	0.0008
τ_i (s)	0.7682	0.1902	0.0078	0.0000

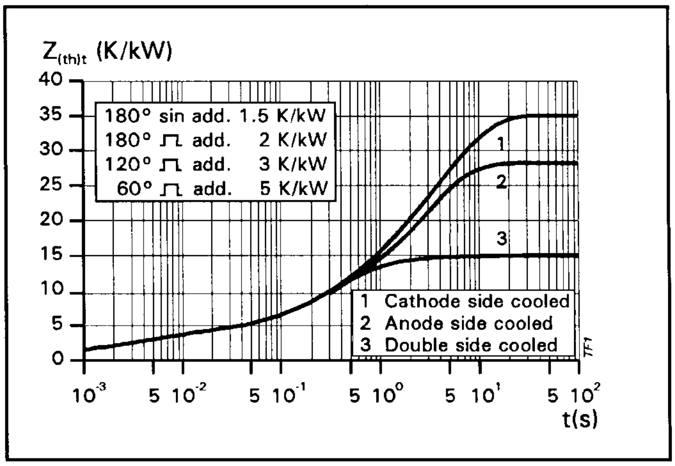

Fig.1 Transient thermal impedance, junction to case.

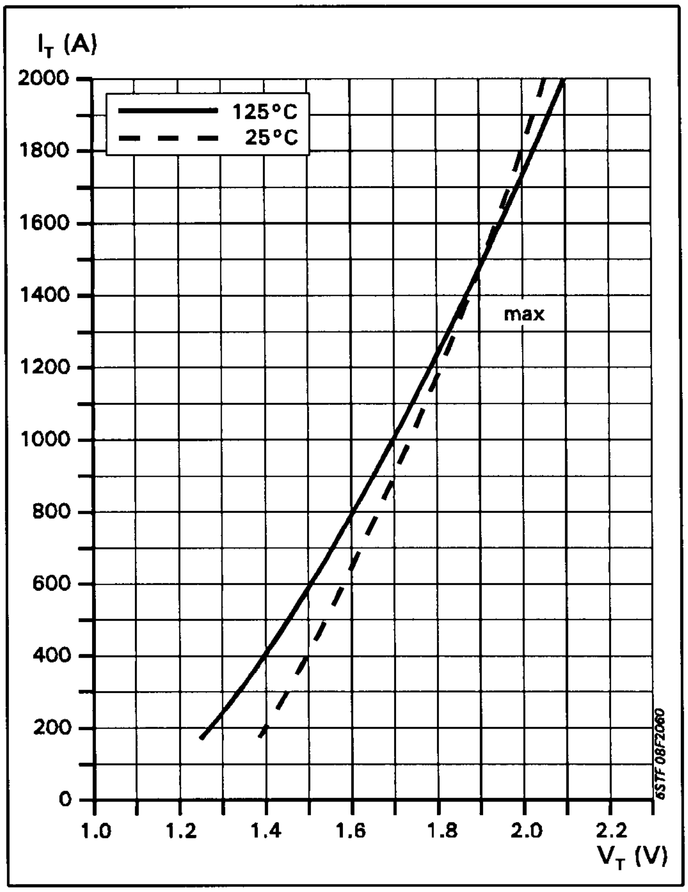

Fig.2 On-state characteristics.

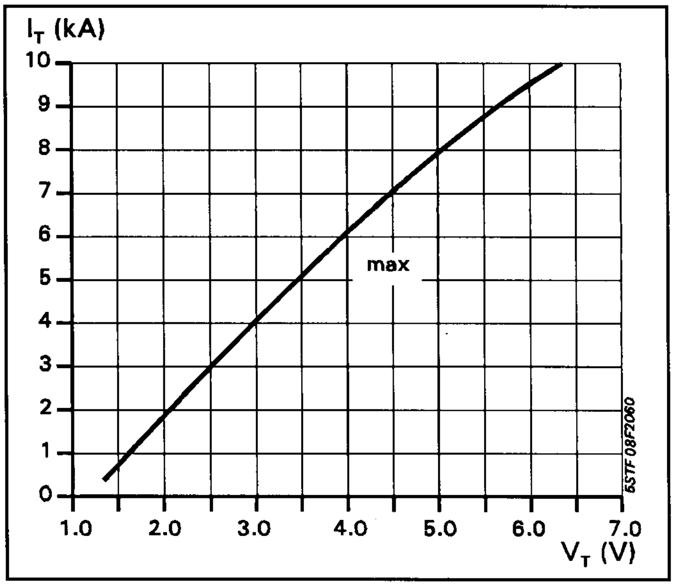

Fig.3 On-state characteristics.

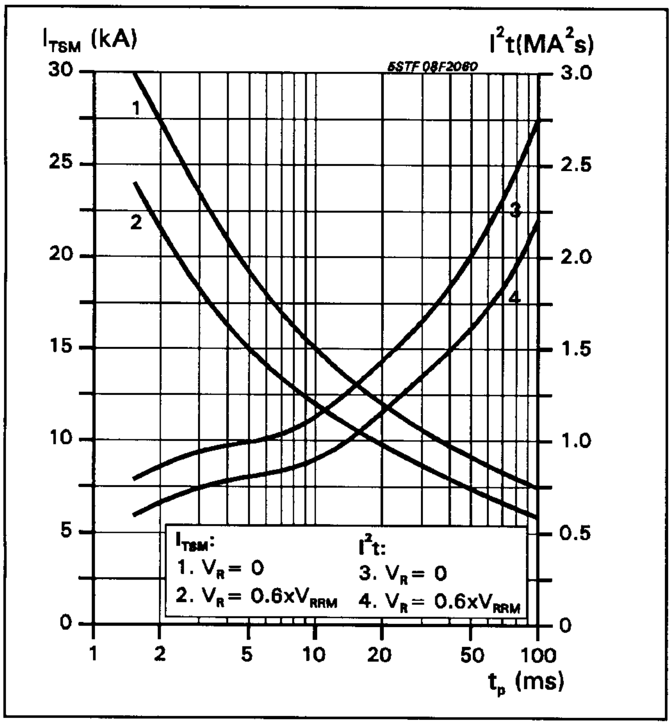

Fig.4 Surge on-state current vs pulse length. Half-sine wave.

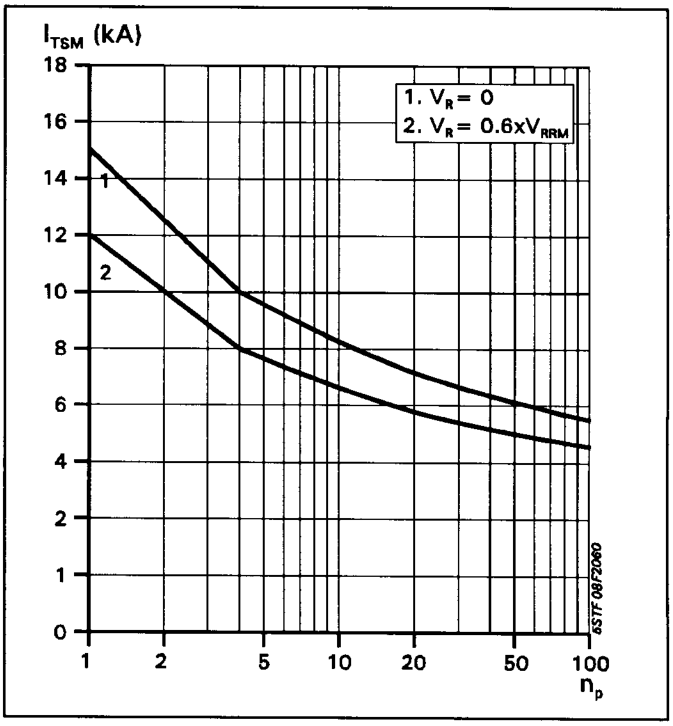

Fig.5 Surge on-state current vs number of pulses. Half-sine wave, 10ms, 50Hz.

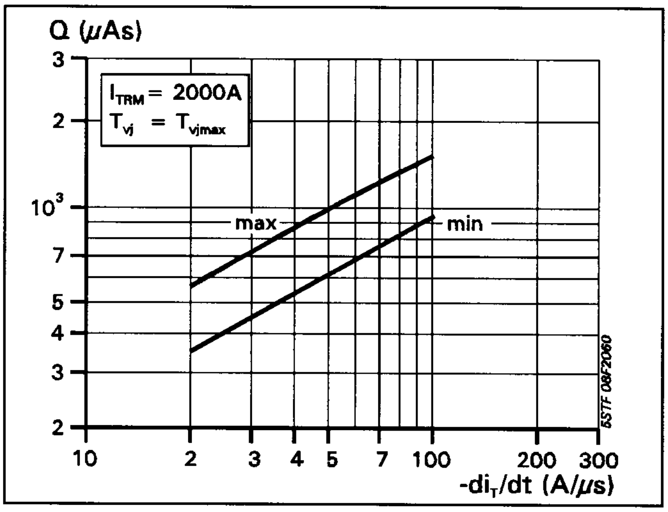

Fig.6 Recovery charge vs decay rate of on-state current.

ABB Semiconductors AG

Fabrikstrasse 3
CH-5600 Lenzburg, Switzerland

Telephone +41 (0)62 888 6419
Fax +41 (0)62 888 6306

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